

N-channel 100 V 5 mΩ standard level MOSFET in D2PAK Rev. 01 — 24 December 2010 Objective data

Objective data sheet

Product profile 1.

1.1 General description

Standard level N-channel MOSFET in a D2PAK package qualified to 175 °C. This product is designed and qualified for use in a wide range of industrial, communications and domestic equipment.

1.2 Features and benefits

- High efficiency due to low switching and conduction losses
- Suitable for standard level gate drive sources

1.3 Applications

- DC-to-DC converters
- Load switching

- Motor control
- Server power supplies

1.4 Quick reference data

Table 1. **Quick reference data**

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Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C		-	-	100	V
I _D	drain current	T _{mb} = 25 °C; V _{GS} = 10 V; see <u>Figure 1</u>	<u>[1]</u>	-	-	120	A
P _{tot}	total power dissipation	$T_{mb} = 25 \text{ °C}; \text{ see } \frac{\text{Figure 2}}{\text{Figure 2}}$		-	-	306	W
Tj	junction temperature			-55	-	175	°C
Static cha	racteristics						
R _{DSon}	drain-source on-state resistance	V _{GS} = 10 V; I _D = 25 A; T _j = 100 °C; see <u>Figure 12</u>		-	6.8	8	mΩ
		V _{GS} = 10 V; I _D = 25 A; T _j = 25 °C; see <u>Figure 13</u>		-	4.3	5	mΩ



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Table 1. Quick reference data ... continued

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Dynamic o	characteristics					
Q _{GD}	gate-drain charge	$V_{GS} = 10 \text{ V}; \text{ I}_{D} = 75 \text{ A};$	-	49	-	nC
Q _{G(tot)}	total gate charge	V _{DS} = 50 V; see <u>Figure 14</u> ; see <u>Figure 15</u>	-	170	-	nC
Avalanche	e ruggedness					
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; I _D = 120 A; V_{sup} ≤ 100 V; R _{GS} = 50 Ω; Unclamped	-	-	537	mJ

[1] Continious current limited by package.

2. Pinning information

Table 2.	Pinning	information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		_
2	D	drain	mb	
3	S	source		
mb	D	mounting base; connected to drain		mbb076 S
			SOT404 (D2PAK)	

3. Ordering information

Table 3.	Ordering in	formation		
Type num	ber	Package		
		Name	Description	Version
PSMN5R0	-100BS	D2PAK	plastic single-ended surface-mounted package (D2PAK); 3 leads (one lead cropped)	SOT404

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4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

		5, 1, 7				
Symbol	Parameter	Conditions		Min	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C		-	100	V
V _{DGR}	drain-gate voltage	T _j ≥ 25 °C; T _j ≤ 175 °C; R _{GS} = 20 kΩ		-	100	V
V _{GS}	gate-source voltage			-20	20	V
I _D	drain current	V _{GS} = 10 V; T _j = 100 °C; see <u>Figure 1</u>		-	120	А
		V_{GS} = 10 V; T_{mb} = 25 °C; see <u>Figure 1</u>	<u>[1]</u>	-	120	А
I _{DM}	peak drain current	pulsed; t _p ≤ 10 µs; T _{mb} = 25 °C; see <u>Figure 3</u>		-	680	А
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>		-	306	W
T _{stg}	storage temperature			-55	175	°C
Tj	junction temperature			-55	175	°C
T _{sld(M)}	peak soldering temperature			-	260	°C
Source-drai	n diode					
Is	source current	T _{mb} = 25 °C	<u>[1]</u>	-	120	А
I _{SM}	peak source current	pulsed; $t_p \le 10 \ \mu s$; $T_{mb} = 25 \ ^{\circ}C$		-	680	А
Avalanche r	uggedness					
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; I_D = 120 A; $V_{sup} \le 100$ V; R_{GS} = 50 Ω ; Unclamped		-	537	mJ

[1] Continious current limited by package.

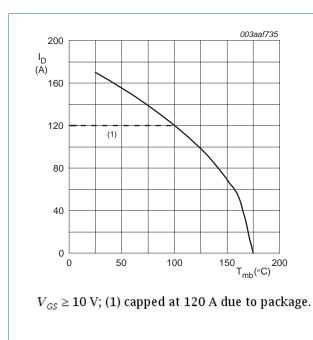
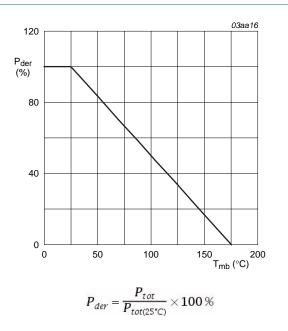


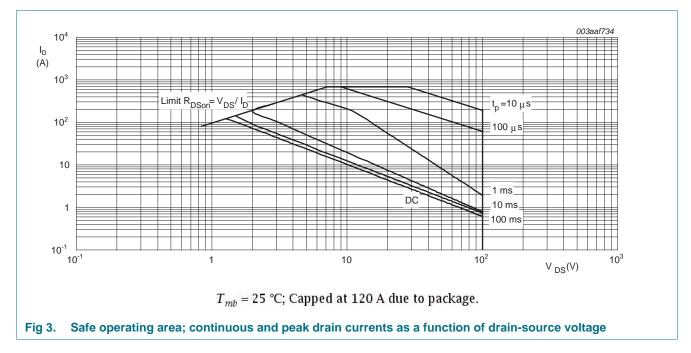
Fig 1. Continuous drain current as a function of mounting base temperature





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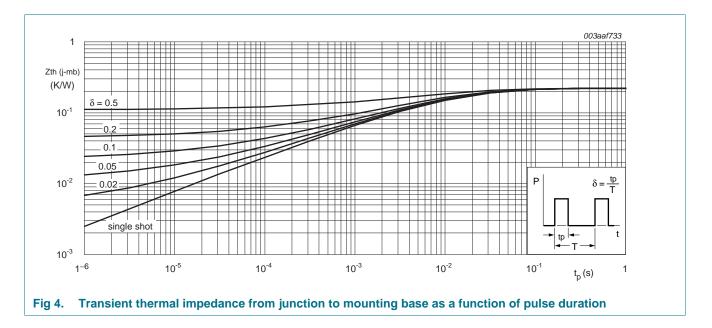
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5. Thermal characteristics

Table 5.Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-mb)}	thermal resistance from junction to mounting base	see <u>Figure 4</u>	-	0.22	0.49	K/W
R _{th(j-a)}	thermal resistance from junction to ambient	vertical in free air	-	60	-	K/W



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6. Characteristics

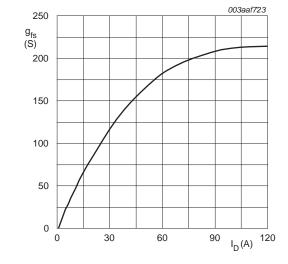
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static chara	cteristics					
V _{(BR)DSS}	drain-source	I _D = 250 μA; V _{GS} = 0 V; T _j = 25 °C	100	-	-	V
· · /	breakdown voltage	I _D = 250 μA; V _{GS} = 0 V; T _i = -55 °C	90	-	-	V
V _{GS(th)}	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C};$ see <u>Figure 10</u> ; see <u>Figure 11</u>	2	3	4	V
V _{GSth}	gate-source threshold voltage	I _D = 1 mA; V _{DS} = V _{GS} ; T _j = 175 °C; see <u>Figure 11</u>	1	-	-	V
		I _D = 1 mA; V _{DS} = V _{GS} ; T _j = -55 °C; see <u>Figure 11</u>	-	-	4.6	V
I _{DSS}	drain leakage current	V _{DS} = 100 V; V _{GS} = 0 V; T _j = 25 °C	-	0.08	1	μA
		$V_{DS} = 100 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 175 \text{ °C}$	-	250	500	μA
I _{GSS}	gate leakage current	V _{GS} = -20 V; V _{DS} = 0 V; T _j = 25 °C	-	10	100	nA
		V _{GS} = 20 V; V _{DS} = 0 V; T _j = 25 °C	-	10	100	nA
R _{DSon}	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; \text{ I}_{D} = 25 \text{ A}; \text{ T}_{j} = 175 \text{ °C};$ see <u>Figure 12</u>	-	8.9	10.5	mΩ
	V _{GS} = 10 V; I _D = 25 A; T _j = 100 °C; see <u>Figure 12</u>	-	6.8	8	mΩ	
		V _{GS} = 10 V; I _D = 25 A; T _j = 25 °C; see <u>Figure 13</u>	-	4.3	5	mΩ
R _G	gate resistance	f = 1 MHz	-	0.9	-	Ω
Dynamic ch	aracteristics					
Q _{G(tot)}	total gate charge	$I_D = 75 \text{ A}; V_{DS} = 50 \text{ V}; V_{GS} = 10 \text{ V};$ see <u>Figure 14</u> ; see <u>Figure 15</u>	-	170	-	nC
		$I_D = 0 A$; $V_{DS} = 0 V$; $V_{GS} = 10 V$; see <u>Figure 14</u> ; see <u>Figure 15</u>	-	140	-	С
Q _{GS}	gate-source charge	I _D = 75 A; V _{DS} = 50 V; V _{GS} = 10 V; see <u>Figure 15</u>	-	48	-	nC
Q _{GS(th)}	pre-threshold gate-source charge	$I_D = 75 \text{ A}; V_{DS} = 50 \text{ V}; V_{GS} = 10 \text{ V};$ see <u>Figure 14</u> ; see <u>Figure 15</u>	-	31	-	С
Q _{GS(th-pl)}	post-threshold gate-source charge		-	17.3	-	С
Q _{GD}	gate-drain charge		-	49	-	nC
V _{GS(pl)}	gate-source plateau voltage	V _{DS} = 50 V; see <u>Figure 14;</u> see <u>Figure 15</u>	-	5.1	-	V
C _{iss}	input capacitance	$V_{DS} = 50 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$	-	9900	-	pF
C _{oss}	output capacitance	T _j = 25 °C; see Figure 16	-	660	-	pF
C _{rss}	reverse transfer capacitance		-	381	-	pF
d(on)	turn-on delay time	$V_{DS} = 50 \text{ V}; \text{ R}_{L} = 0.67 \Omega; \text{ V}_{GS} = 10 \text{ V};$	-	45	-	ns
·r	rise time	$R_{G(ext)} = 4.7 \ \Omega; \ I_D = 75 \ A; \ T_j = 25 \ ^\circ C$	-	91	-	ns
t _{d(off)}	turn-off delay time		-	121.5	-	ns
t _f	fall time		-	63.3	-	ns

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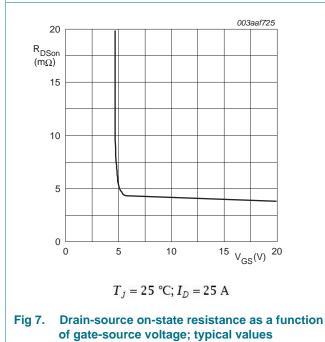
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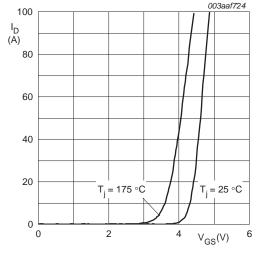
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Source-d	rain diode						
V _{SD}	source-drain voltage	I _S = 25 A; V _{GS} = 0 V see <u>Figure 17</u>	/; T _j = 25 °C;	-	0.8	1.2	V
t _{rr}	reverse recovery time	I_{S} = 25 A; dI_S/dt = -100 A/µs; V_{GS} = 0 V; V_{DS} = 50 V		-	75	-	ns
Qr	recovered charge			-	235	-	nC
250		003aaf723	100		(003aaf724	



$T_j = 25 \text{ °C}; V_{DS} = 25 \text{ V}$

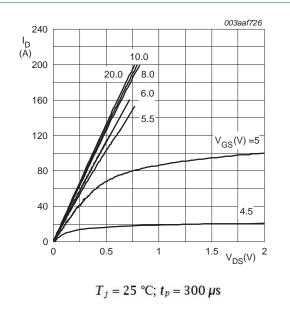












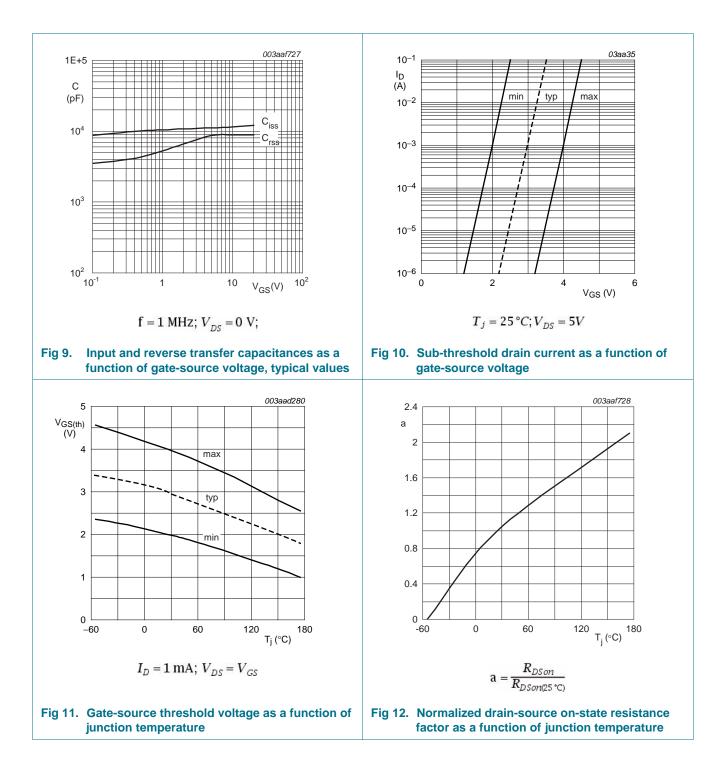


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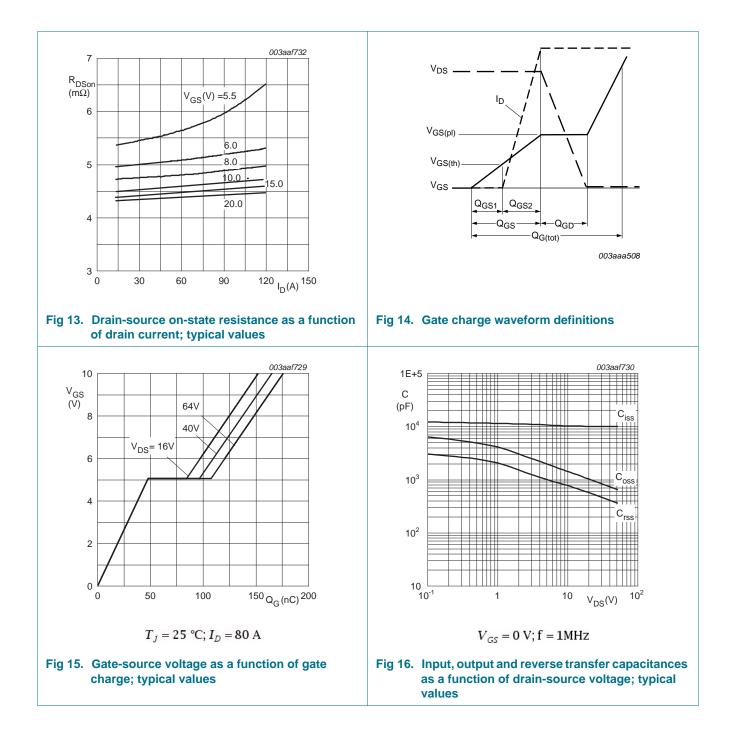
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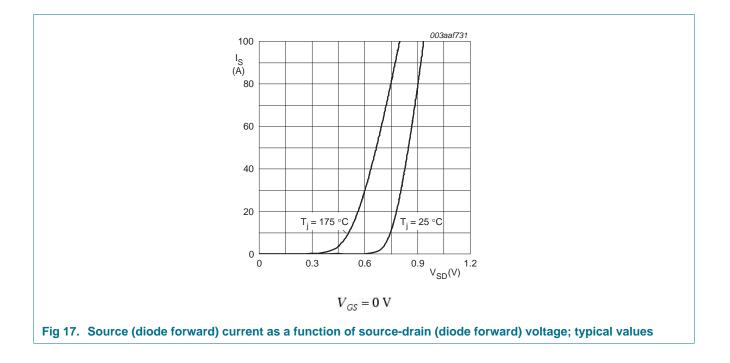
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7. Package outline

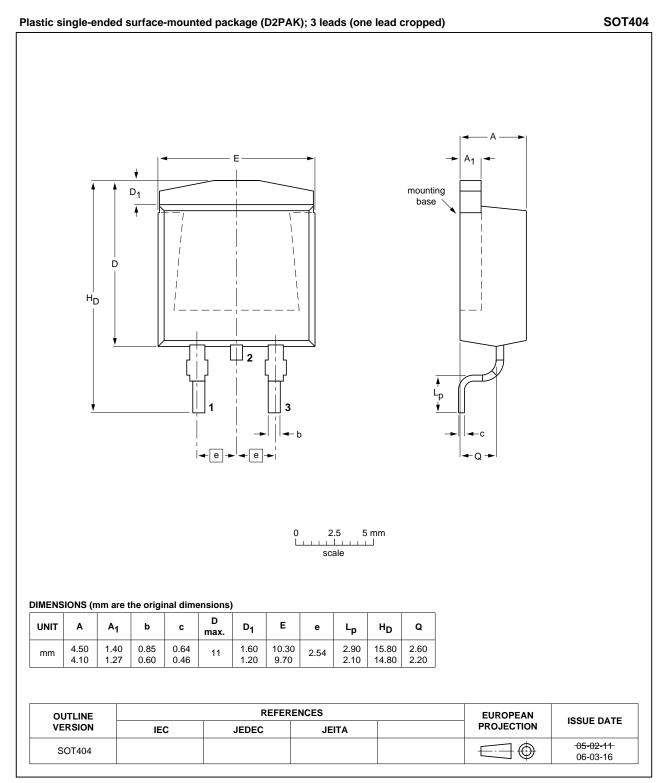


Fig 18. Package outline SOT404 (D2PAK)

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8. Revision history

Table 7. Revision history						
Document ID	Release date	Data sheet status	Change notice	Supersedes		
PSMN5R0-100BS v.1	20101224	Objective data sheet	-	-		

9. Legal information

9.1 Data sheet status

Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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